## TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL DUAL GATE MOS TYPE

## 3 S K 2 5 7

TV TUNER, VHF RF AMPLIFIER APPLICATIONS FM TUNER APPLICATIONS TV TUNER, UHF RF AMPLIFIER APPLICATIONS

- Superior Cross Modulation Performance.
- Low Noise Figure: NF=2.0dB (Typ.)

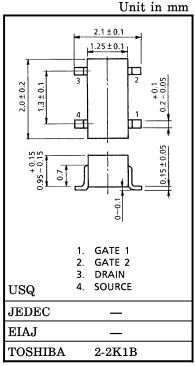
## MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	$v_{ m DS}$	13.5	V
Gate 1-Source Voltage	$v_{G1S}$	±8	V
Gate 2-Source Voltage	$v_{G2S}$	±8	V
Drain Current	$I_{\mathrm{D}}$	30	mA
Drain Power Dissipation	$P_{\mathbf{D}}$	100	mW
Chanel Temperature	$\mathrm{T_{ch}}$	125	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

## Marking



ELECTRICAL CHARACTERISTICS (Ta = 25°C)



Weight: 0.006g

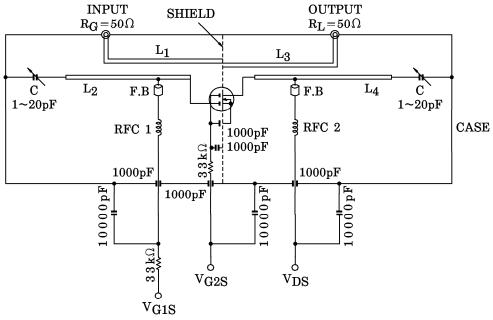
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate 1 Leakage Current	I <sub>G1SS</sub>	$V_{DS} = 0, V_{G1S} = \pm 6V, V_{G2S} = 0$	_	_	±50	nA
Gate 2 Leakage Current	$I_{G2SS}$	$V_{DS} = 0, V_{G1S} = 0, V_{G2S} = \pm 6V$	_	_	±50	nA
Drain-Source Voltage	V <sub>(BR)</sub> DSX	$V_{G1S} = -1V, V_{G2S} = -1V$ $I_D = 100 \mu A$	13.5	_	_	V
Drain Current	I <sub>DSS</sub>	$egin{array}{c} V_{ m DS}\!=\!6{ m V},\ V_{ m G1S}\!=\!0,\ V_{ m G2S}\!=\!4.5{ m V} \end{array}$	0	_	0.1	mA
Gate 1-Source Cut-off Voltage	VG1S (OFF)	$V_{DS} = 6V, V_{G2S} = 4.5V, I_{D} = 100 \mu A$	0	_	1.0	V
Gate 2-Source Cut-off Voltage	1	$V_{DS} = 6V, V_{G1S} = 4V, I_{D} = 100 \mu A$	0.5	1.0	1.5	v
Forward Transfer Admittance	Y <sub>fs</sub>	$V_{ m DS} = 6 { m V}, \ V_{ m G2S} = 4.5 { m V} \ I_{ m D} = 10 { m mA}, \ { m f} = 1 { m kHz}$	_	21	_	mS
Input Capacitance	Ciss	V-a-GV V-a-4 EV	_	3.4	4.4	
Reverse Transfer Capacitance	$C_{rss}$	$V_{\mathrm{DS}}$ =6V, $V_{\mathrm{G2S}}$ =4.5V $I_{\mathrm{D}}$ =10mA, f=1MHz	_	0.020	0.05	рF
Power Gain	$G_{\mathrm{ps}}$	$V_{DS}=6V, V_{G2S}=4.5V$	19	22	_	dB
Noise Figure	NF	$I_{\rm D} = 10 {\rm mA, \ f} = 800 {\rm MHz}$	_	2.0	3.5	ub

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The information contained herein is subject to change without notice.

Fig.1  $G_{ps}$ , NF Test Circuit



L1~L4:  $\phi$ 0.8mm SILVER PLATED COPPER WIRE C: AIR TRIMMER TTA25A200A (MURATA MFG. Co., Ltd.) RFC 1:  $\phi$ 0.35mm COPPER WIRE 3mm ID, 7T RFC 2:  $\phi 0.35$ mm COPPER WIRE 3mm ID, 10T

